JAH 1 7 2003 SERIAL NO: 10/056,975 ATTY. DOCKET NO: 5150-63600 Form PTO-1449 (modified) List of Patents and Publications RECEIVED For Applicant's Information JAN 2 1 2003 Disclosure Statement Technelogy Center 2100 (Use several sheets if necessary) APPLICANT: Grey et al. FILING DATE: January 25, 2002 GROUP: -2184-U.S. PATENT DOCUMENTS CLASS SUB FILING DATE IF DATE **NAME** DOCUMENT EXAM. REF. APPROPRIATE **CLASS** INITIALS DES **NUMBER** A1 6,397,378 05/28/2002 Grey et al. Man O'Donnell et al. A2 6,023,773 02/08/2000 Jenkins et al. 12/14/1999 **A3** 6,002,868 01/01/2002 Bauman et al. A4 6,336,088 5,261,097 11/09/1993 **A5** Saxon FOREIGN PATENT DOCUMENTS CLASS SUB TRANSLATION EXAM. REF. **COUNTRY** DOCUMENT DATE YES/NO **CLASS** INITIALS DES NUMBER OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.) National Instruments Corporation, LabVIEW, "Test Executive Reference Manual," August 1997. Han Johnson, Laura, "Test and Measurement – Understanding Test Executives," Webpage www.testandmeasurement.com.content/news/, October 16, 2000, pages 1-9. EXAMINER: Howay Centonish museuBa DATE CONSIDERED: EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the patent owner.

Information Disclosure Statement--PTO 1449 (modified)

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